











#### Type

# **MICRO-KLEPS**

Miniature clamp-type test probe with rotating grip jaws (SMD technology). The insulated shaft can be bent up to 35°. Suitable for very thin wires and densely packed contact points (1.27 mm IC spacing pitch). Connects with MKL... and MAL...

Clamping range Clamp type

PART NO. / Housing color

2 mm

rotating grip jaws

973972100 973972101

# **KLEPS 3 ST**

Miniature clamp-type test probe with rotating grip jaws. Suitable for very thin wires and densely packed contacts. Connects with MKL... and

3.5 mm rotating grip jaws

973592100 973592101

### **Technical data**

Type of termination

Rated voltage

Measurment cat. acc. to IEC61010

Rated current\* Contact resistance

**Material Specifications** 

Contact material

Contact surface material

Housing material

**Environmental conditions** 

Temperature range Inflamability class

Housing (basic material)

2x pin Ø 0.64 mm

30 VAC / 60 VDC

2 A

10 mOhm

grip jaws: spring steel, pin: brass

grip jaws: tin, pin: nickel

-25 °C to +100 °C

**UL 94 HB** 

pin Ø 0.64 mm 30 VAC / 60 VDC

CAT I

2 A

10 mOhm

grip jaws: spring steel, pin: brass

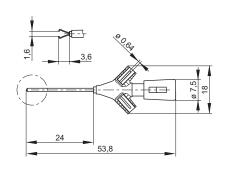
grip jaws: tin, pin: nickel

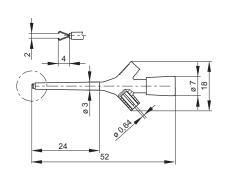
PBT

-25 °C to +100 °C

**UL 94 HB** 

Measurements are shown in millimeters. Multiply by 0.03937 to convert to inches.





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